
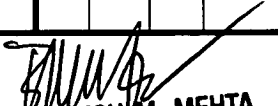


<b>Issue Classification</b> 	<b>Application/Control No.</b> 10/716,870	<b>Applicant(s)/Patent under Reexamination</b> KAWATO ET AL.
	<b>Examiner</b> Alex Liew	<b>Art Unit</b> 2624

ISSUE CLASSIFICATION											
ORIGINAL					INTERNATIONAL CLASSIFICATION						
CLASS		SUBCLASS			CLAIMED					NON-CLAIMED	
382		118			G	6	K	9	/00		/
CROSS REFERENCES									/		/
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)								/		/
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Alex Liew 12/23/07 (Assistant Examiner) (Date)					 <b>BHAVESH M. MEHTA</b> <b>SUPERVISORY PATENT EXAMINER</b> (Principal Examiner) (Date) TECHNOLOGY CENTER 2600					Total Claims Allowed: 15	
(Legal Instruments Examiner) (Date)										O.G. Print Claim(s) 1	

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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